


<p style="text-align: center;">Search Notes</p> 	<p>Application/Control No.</p> <p>10534418</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>DEL PRADO PAVON ET AL.</p>
	<p>Examiner</p> <p>Mack, Sylvia</p>	<p>Art Unit</p> <p>2617</p>

SEARCHED			
Class	Subclass	Date	Examiner
370	229	4/27/2007	SM
	338	4/27/2007	SM
	448	4/27/2007	SM
	449	4/27/2007	SM
370	229	12/22/2007	SM
	338	12/22/2007	SM
	448	12/22/2007	SM
	449	12/22/2007	SM

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted SPE- Nick Corsaro	4/26/2007	SM
EAST Image and Keyword search in USPAT, US-PGPUB, DERWENT, EPO, JPO, IBM, TDB	4/26/2007	SM
370/229 (text search only - see search history printout)	4/27/2007	SM
370/338 (text search only - see search history printout)	4/27/2007	SM
370/448 (text search only - see search history printout)	4/27/2007	SM
370/449 (text search only - see search history printout)	4/27/2007	SM
NPL: STIC 2600, Internet, IEEE Xplore, Inventor Name Search	4/27/2007	SM
EAST Image and Keyword search in USPAT, US-PGPUB, DERWENT, EPO, JPO, IBM, TDB	12/22/2007	SM
NPL: STIC 2600, Internet, IEEE Xplore, Inventor Name Search	12/22/2007	SM
370/229, 338, 448, 449 (text search only - see search history printout)	12/22/2007	SM

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner